

**Notice of References Cited**

Application/Control No.

10/576,480

Applicant(s)/Patent Under

Reexamination

INOUE ET AL.

Examiner

PETER J. BERTHEAUD

Art Unit

3746

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,288,212	02-1994	Lee, In S.	417/312
*	B US-5,496,156	03-1996	Harper et al.	417/312
*	C US-4,313,715	02-1982	Richardson, Jr., Hubert	417/312
*	D US-4,370,104	01-1983	Nelson et al.	417/312
*	E US-6,129,522	10-2000	Seo, Seung-don	417/312
*	F US-5,804,777	09-1998	Kim et al.	181/229
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
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